

Notice of References Cited	Application/Control No. 10/600,377	Applicant(s)/Patent Under Reexamination HOU ET AL.	
	Examiner DuyVu n Deo	Art Unit 1765	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-6,284,612	09-2001	Wu, Shye-Lin	438/305
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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